

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/618,820	CHEN ET AL.
	Examiner	Art Unit
	Steven E. Holton	2673

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Sens	1s 1bune	2/2/06	SEH
Interference Search		2/1/2006	SEH